

Effect of Cs-Incorporated NiO_x on the Performance of Perovskite Solar Cells

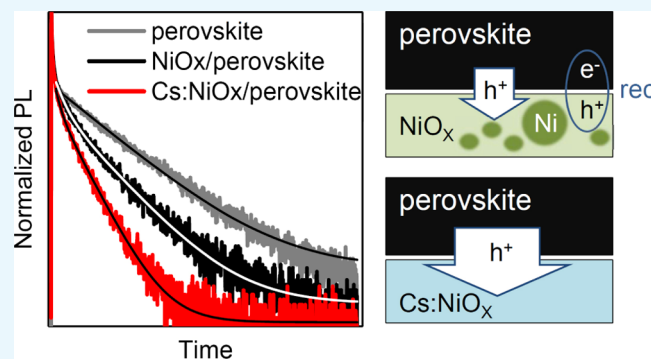
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Supporting Information

ABSTRACT: The effect of Cs-incorporated NiO_x on perovskite solar cells with an inverted structure was investigated, where NiO_x and PCBM were used as selective contacts for holes and electrons, respectively. It was found that the generation of an Ni phase in an NiO_x layer was significantly suppressed by employing cesium. Furthermore, Cs-incorporated NiO_x enabled holes to be efficiently separated at the interface, showing the improved photoluminescent quenching and thus generating higher short-circuit current. The effect of Cs incorporation was also prominent in the inhibition of recombination. The recombination resistance of Cs-incorporated NiO_x was noticeably increased by more than three-fold near the maximum power point, leading to a higher fill factor of 0.78 and consequently a higher power conversion efficiency



of 17.2% for the device employing Cs-incorporated NiO_x.

INTRODUCTION

Since 2012, the perovskite solar cells unexpectedly have been attracting interest owing to their remarkable potential for high efficiency and stability,^{1,2} and intensive studies on perovskite solar cells have been extensively carried out, leading to outstanding achievements in terms of efficiency, stability, and understanding of underlying mechanisms. Various methods have been successfully developed to enhance the quality of the perovskite layer by controlling the film growth.^{3–8} Among them, the adduct⁸ and the antisolvent⁴ methods became the two most popular methods for the current technology of high-efficiency perovskite solar cells. Furthermore, multiple cations, such as methylammonium (MA⁺), formamidinium (FA⁺), cesium (Cs⁺), and rubidium (Rb⁺), were efficiently incorporated into the perovskite to stabilize its phase as well as to achieve the high efficiency of 21.6%.⁹ The most common perovskite configuration which has been intensively studied is the normal structure based on TiO₂ as an electron transport layer and 2,2',7,7'-tetrakis (*N,N*-di-*p*-methoxyphenylamine)-9,9'-spirobifluorene (spiro-MeOTAD) as a hole transport layer. Even though the perovskite device with a TiO₂/perovskite/spiro-MeOTAD structure is the one used in the efficiency chart,¹⁰ it still has certain problems to be solved. It was found that those selective contacts, TiO₂ and spiro-MeOTAD, coupled with halide perovskites, induced time-dependent behaviors,^{11–16} which are sufficiently observable in the range

of solar cell operation, such as *I*–*V* hysteresis^{11–14} and/or interfacial dynamics related to the ion migration from the perovskite bulk layer.^{13–16} These complicating mechanisms at the interface are not fully understood and also imply the negative effect on long-term stability.^{16,17} Also, spiro-MeOTAD itself is easily crystallized at high temperatures,^{18,19} underlying limitations on future commercial development. Unlike the normal structure, the inverted structure employing NiO_x and [6,6]-phenyl-C₆₀-butyric acid methyl ester (PCBM) as hole and electron selective contacts demonstrated superb air and thermal stability¹⁸ with hysteresis-free characteristics based on its fast response time.¹⁴ Besides, many efforts have been made on achieving high efficiency close to that of the normal structure.^{20–22} Since the initial works on the inverted structure with NiO_x and PCBM in 2014 to replace unstable organic hole transport layers and obtain better energy level alignment,^{23–25} Mg and Li co-doping was tried to increase the conductivity of NiO_x as well as tune the band alignment with perovskites, which resulted in a power conversion efficiency (PCE) of 16.2%.²⁰ Cu-doped NiO_x was also reported and demonstrated 17.8% of perovskite solar cells because of its high crystallinity and improved conductivity.²¹ Nevertheless, a few papers were

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published compared to the normal structure where every single selective contact was carefully engineered to enhance the performance. In this study, cesium is employed in the NiO_x layer to improve the performance of the inverted perovskite solar cells. The effect of cesium is investigated in respect of the inhibition of Ni phase formation in the NiO_x bulk layer as well as the efficient charge-transfer behavior at the NiO_x/perovskite interface. In the end, both aspects are closely related to the photovoltaic performance.

RESULTS AND DISCUSSION

Figure 1a shows X-ray diffraction (XRD) patterns of NiO_x and Cs-incorporated NiO_x powders. To collect the powders for

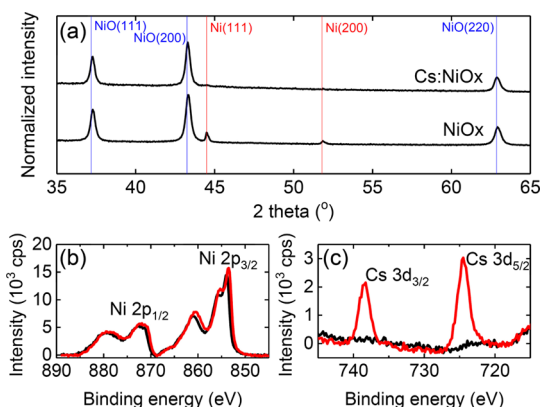


Figure 1. (a) Normalized XRD patterns of NiO_x and Cs-incorporated NiO_x (Cs/NiO_x). (b) Ni 2p and (c) Cs 3d XPS spectra of NiO_x and Cs/NiO_x. The sample was prepared as a powder in the same manner as for the film. Black and red lines indicate NiO_x and Cs/NiO_x, respectively.

XRD measurements, the NiO_x precursor solutions were prepared and heated in the same manner as the NiO_x layer for devices. XRD peaks shown at 37.18°, 43.25°, and 62.86° (blue vertical lines in Figure 1a) correspond respectively to (111), (200), and (220) planes of the NiO phase according to JCPDS (22-1189). It is noted that an Ni metal phase is observed from the NiO_x sample at 44.5° and 51.8° (red vertical lines in Figure 1a) corresponding to (111) and (200) planes for Ni.²⁶ A ratio quantification of Ni to NiO was obtained by the Rietveld refinement, showing a ratio of 0.16:0.84. Interestingly, the Ni impurity is significantly suppressed by employing 1 mol % cesium in the precursor solution (Cs/NiO_x). It was confirmed by the energy-dispersive X-ray spectroscopy (EDXS), showing that 0.7 at. % Cs was included in NiO_x. The ionic radii of Ni²⁺ and Cs⁺ were found to be 0.69 and 1.67

Å, respectively.^{27,28} When considering the large size difference between them, it is difficult to substitute Cs⁺ for Ni²⁺ as in the general Li⁺ doping. Nevertheless, cesium nickel oxide, Cs_{0.1}NiO₂, has the same crystal system and space group as NiO (Table S1), which suggests that a small amount of Cs might occupy Ni vacancies and be incorporated to the NiO_x lattice. Because the error range for the XRD measurement used in this study is within $2\theta \leq \pm 0.0065^\circ$, the peak shift from 43.31° to 43.28° indicates the slight increase of the lattice parameter due to the larger size of Cs⁺ compared to the Ni²⁺. X-ray photoelectron spectroscopy (XPS) spectra of nickel oxide are shown in Figure 1b, where peaks near 872 and 854 eV are attributed to Ni 2p_{2/1} and Ni 2p_{3/2}, respectively. Ni 2p_{3/2} XPS spectra incorporate Ni²⁺ at 854.5 eV and Ni³⁺ at 855.8 eV for both NiO_x and Cs-incorporated NiO_x (Cs/NiO_x),²⁹ which implies that both NiO and Ni₂O₃ phases are mixed in nickel oxide irrespective of Cs incorporation. It is noted that Ni⁰ at 852.9 eV is not clearly seen in Ni 2p_{3/2} XPS spectra for NiO_x employing the Ni phase (Figure 1a), suggesting that the Ni phase is formed from bulk NiO_x and leaves the oxidized form (NiO_x) on the surface. In Figure S1, the Ni⁰ peak is observed from the NiO_x sample after milling, indicating the presence of Ni⁰ inside bulk. In Figure 1c, XPS peaks corresponding to Cs 3d_{3/2} (738.4 eV) and Cs 3d_{5/2} (724.6 eV) are clearly observed from Cs/NiO_x while NiO_x shows the absence of Cs 3d spectra.³⁰ The XPS result of Cs/NiO_x indicates that 0.8 at. % Cs is incorporated in NiO_x, which is consistent with the estimation from EDXS (0.7 at. %).

A 25 nm thick dense NiO_x film was prepared by a solution process and employed in the device. The morphologies of the NiO_x and Cs-incorporated NiO_x films on the fluorine-doped tin oxide (FTO) glass are shown in Figure S2. It is found that the Cs-incorporated NiO_x layer (Figure S2b) results in more rough surface morphology compared to the NiO_x layer (Figure S2a). However, it makes little difference in the perovskite morphology whether the perovskite is grown on NiO_x (Figure S2c) or on Cs-incorporated NiO_x (Figure S2d). Both perovskite films deposited by the antisolvent method⁹ produce flat and large grain whose size ranges from 50 to 400 nm.

Perovskite films deposited on the NiO_x and Cs-incorporated NiO_x substrates showed similar absorbance spectra, which are shown in Figure 2a, indicating a negligible difference in light harvesting efficiency. Photoluminescence (PL) was measured for perovskite films to investigate the effect of the NiO_x layer on charge separation. For perovskites, 450 nm was used as an excitation wavelength, and the incidence was made from the FTO/NiO_x (glass) side for steady-state PL. PL spectra of the perovskite film deposited on the glass substrate without any quenching layer are shown in Figure S2a. The radiative recombination is mainly determined by the band gap energy,

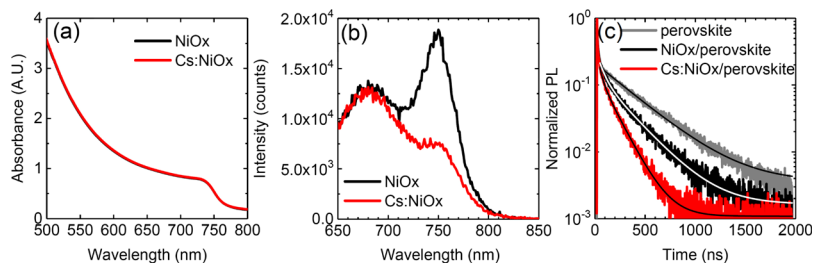


Figure 2. (a) Absorbance and (b) PL spectra of the perovskite film deposited on NiO_x (black) and Cs-incorporated NiO_x (red) substrates. (c) TR-PL of the perovskite film based on the glass (gray), FTO/NiO_x (black), and FTO/Cs-incorporated NiO_x (red) substrates with fitted curves.

leading to a large emission at 750 nm which corresponds to the band gap of the perovskite. The PL peak at 680 nm comes from the FTO glass itself (Figure S3b). In Figure 2b, the perovskite attached to the NiO_x layer shows a significantly decreased PL at 750 nm, which is attributed to the carrier injection to the adjacent selective contact inhibiting the radiative recombination in the material. NiO_x is used as a hole selective contact and is responsible for hole separation. Noticeably, perovskites with the NiO_x layer still showed a clear peak at 750 nm because of the remaining hole carriers in the perovskites. It is found that Cs-incorporated NiO_x enables holes to be separated more efficiently, diminishing the PL intensity at 750 nm even more than bare NiO_x (Figure 2b).

Time-resolved PL (TR-PL) measurements were carried out to have more insight on the Cs-doping effect. TR-PL spectra of perovskite films with different substrates are shown in Figure 2c. A 408 nm single wavelength was used as an excitation source, and 750 nm of wavelength was monitored as a result of recombination. The TR-PL spectra were fitted to estimate the PL life time quantitatively by using one- or two-component exponential decay.^{31,32} The fitting results and the estimated values from fittings are shown in Figure 2c and Table 1. For the

Table 1. Carrier Life Time of Perovskite Films According to the TR-PL Fitting with Exponential Decay

time component	perovskite (ns)	NiO _x /perovskite (ns)	Cs/NiO _x /perovskite (ns)
τ_1	349.1	262.4	146.5
τ_2		58.0	32.5

perovskite film without NiO_x, a one-component exponential decay fit well to the results, indicating that a first order is dominant in the perovskite layer itself. However, the one-exponential decay brought a considerable discrepancy in the case of the perovskite film with the NiO_x (Cs/NiO_x) substrate, where a two-component exponential decay was used to fit the results. While the slow decay component (τ_1) is still found in a comparable range with the one observed from the bare perovskite film, the fast decay component (τ_2) is newly developed by attaching the quenching layer. Consequently, the slow decay component (τ_1) is mostly determined by the recombination of carriers in the perovskite,^{31,32} and the fast decay component (τ_2) is affected by quenching of the carriers³² because of the hole selective contact (NiO_x) in this study. As expected, the perovskite film on the glass without any quenching layer has the longest τ_1 of 349.1 ns. Adding the NiO_x layer to the perovskite film generates the fast decay component (τ_2) of 58.0 ns because of the effective hole quenching at the interface, which seems to have an effect on free carrier recombination in bulk perovskites with a shortening of τ_1 to 263.4 ns. The shortened τ_1 could be attributed to the increased electron density in the vicinity of the hole selective contact, which can sufficiently facilitate the recombination near the contact. Both decay components are even more reduced to 146.5 ns for τ_1 and to 32.5 ns for τ_2 by employing Cs into NiO_x, indicating that the hole transfer at the interface becomes more accelerated for Cs/NiO_x. The observed improved hole separation could be ascribed to either the increased interface area (Figure S2b) or the removal of the Ni phase by Cs incorporation.

We found that employing Cs into NiO_x leads to more efficient hole injection at the interface according to PL data. In

terms of charge collection, the charge transfer in the selective contact medium itself should be considered at the same time. The resistivity is increased from $8.1 \times 10^4 \Omega \text{ cm}$ for NiO_x to $15.2 \times 10^4 \Omega \text{ cm}$ for Cs/NiO_x. The increase in resistivity can be attributed to the synthesis method,^{33,34} the formation of secondary phases,³⁵ or to scattering effects³⁵ as reported earlier for Li-doped NiO_x. Although there are no electrical properties available for Cs_{0.1}NiO₂ or Cs₂NiO₂, taking into account that Cs₂O is a n-type semiconductor and Cs₂O₂ is an insulator,^{36,37} the inclusion of Cs into NiO_x could reduce the p-type conductivity and thus increase the resistivity. However, the slight increase in resistivity by Cs incorporation seems unlikely to exceed other beneficial effects by Cs incorporation.

The photovoltaic performance was measured based on the inverted structure, where NiO_x or Cs/NiO_x was employed as the hole transport material, and PCBM was used as the electron transport material (inset of Figure 3a). Figure 3a shows the *I*–*V*

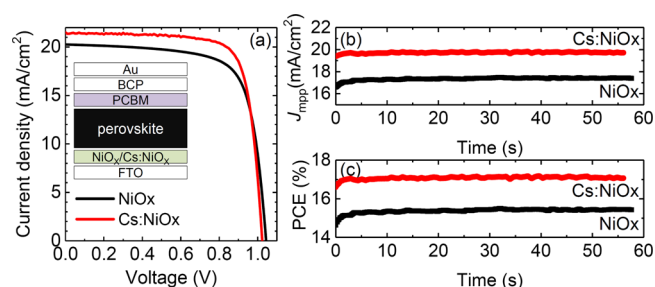


Figure 3. (a) *I*–*V* curves of perovskite solar cells based on NiO_x (black) and Cs-incorporated NiO_x (red). The inset figure in (a) shows the schematic structure of the inverted device. Time-dependent (b) photocurrent density and (c) PCE at the maximum power point.

curves for the perovskite solar cells with NiO_x and Cs/NiO_x, and the corresponding photovoltaic parameters are shown in Table 2. The statistical photovoltaic parameters are shown in

Table 2. Photovoltaic Parameters of Perovskite Solar Cells Based on NiO_x and Cs-Incorporated NiO_x

	J_{sc} (mA/cm ²)	V_{oc} (V)	FF	PCE (%)
NiO _x	20.4	1.04	0.72	15.3
Cs/NiO _x	21.4	1.03	0.78	17.2

Figure S4 and Table S2. The *I*–*V* curves were obtained with a forward scan from open circuit to short circuit. Both devices show a hysteresis-free behavior even with 1 ms for the voltage settling time, as shown in Figure S5, indicating that the steady-state condition is rapidly reached. The device with Cs/NiO_x demonstrates a higher PCE of 17.2% (15.9% for average) than that of 15.3% (13.8% for average) for the NiO_x, mainly because of the higher short-circuit photocurrent density (J_{sc}) and the fill factor (FF). The Cs/NiO_x device shows 21.4 mA/cm² of J_{sc} and 0.78 of FF, whereas 20.4 mA/cm² of J_{sc} and 0.72 of FF are obtained from the NiO_x device. Considering the fact that the light absorbance is comparable for both films (Figure 2a), the efficient and fast charge injection from the perovskite to the hole selective contact is dominantly responsible for the higher J_{sc} for Cs/NiO_x according to PL results (Figure 2b,c).

In Figure 3b,c, the dependence of photocurrent density at the maximum power point (J_{mpp}) and the corresponding evolution of PCE with time are shown. J_{mpp} is a good indicator for the FF. The Cs/NiO_x device with a higher FF obviously

demonstrated higher J_{mpp} . It is noted that both inverted devices show a stable behavior once they reach the saturation point. It is clearly contrary to the behavior of the normal structure whose PCE often gradually goes down after reaching the highest PCE. It must be related to the charge-transfer mechanism at the interface with the selective contact. The understanding of the detailed mechanism is beyond the scope of the current study and will be handled separately. The saturated J_{mpp} reaches 19.7 mA/cm² for Cs/NiO_x and 17.4 mA/cm² for NiO_x (Figure 3b), consequently leading to a PCE of 17.1 and 15.4% for Cs/NiO_x and NiO_x (Figure 3c), respectively.

Impedance spectroscopy (IS) measurements were performed to investigate the recombination resistance, accounting for FF and J_{mpp} . The IS measurement was carried out under the illumination of a white light-emitting diode (LED) with a forward bias ranging from short-circuit to near-open-circuit voltage. Recently, various equivalent circuits have been reported to assign each element to unique characteristics of perovskite solar cells such as ionic movement and polarization.^{38–40} However, these are still controversial. In this study, we used the most common simplified circuit, which is composed of R and R – C circuits in series. Figure 4 shows the recombination

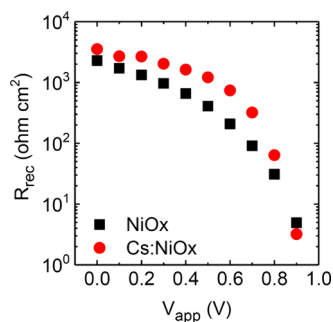


Figure 4. Recombination resistance of perovskite solar cells based on NiO_x (black squares) and Cs-incorporated NiO_x (red circles) under illumination.

resistance (R_{rec}) obtained by fitting the Nyquist plot observed from the low frequency range (Figure S6).^{41,42} The device with Cs/NiO_x shows higher R_{rec} at 0.0–0.8 V compared to the one with NiO_x. The difference in R_{rec} is mostly governed by the recombination near the hole selective contact because the only difference between the two devices is the NiO_x contact. Therefore, the charge recombination is significantly suppressed by the Cs/NiO_x layer with a negligible Ni phase, which could sufficiently act as a recombination center. Otherwise, the accumulated carriers due to the low hole extraction by NiO_x, compared to Cs/NiO_x, can be responsible for the accelerated recombination in bulk perovskites,⁴² leading to the low R_{rec} for NiO_x. The difference between R_{rec} values gradually increases toward the higher voltage region which determines the FF and J_{mpp} . However, the R_{rec} tendency is reversed near V_{oc} , which seems to be responsible for the slightly lower V_{oc} for the device with Cs/NiO_x, implying that the Cs incorporation induces a positive shift in the valence band. The R_{rec} results are well in accordance with the photovoltaic parameters.

In conclusion, the effect of Cs-incorporated NiO_x on the performance of the inverted perovskite solar cells was studied. An employment of Cs in the NiO_x layer was found to effectively suppress the development of an Ni phase in the

NiO_x layer. Furthermore, the Cs-incorporated NiO_x layer enabled holes in perovskites to be efficiently separated and collected, which significantly impeded the recombination at the interface by lowering the hole concentration. Consequently, the perovskite solar cells based on Cs-incorporated NiO_x demonstrated higher PCE mainly because of the higher photocurrent density and FF.

EXPERIMENTAL SECTION

Preparation of Perovskite Precursor Solution. 1.5 M lead iodide (TCI) was prepared where the solvent was a mixture of dimethylformamide (DMF, Acros) and dimethyl sulfoxide (DMSO, Acros) (DMF/DMSO = 4:1 volume ratio). Formamidinium iodide (Dyesol) was added to the 1.5 M PbI₂ solution with a 9% excess molar ratio for PbI₂. A mixture of 1.5 M lead bromide (TCI) and methylammonium bromide (Dyesol) was prepared in the same manner as for 9 mol % excess Pb and mixed solvent. 1.5 M cesium iodide (ABCR, 99.998%) was prepared with DMSO. To make a perovskite precursor solution based on mixed triple cations and double halides, the prepared FAPbI₃, MAPbBr₃, and CsI solutions were mixed in a ratio of 5:1:0.3.

Preparation of Device. An FTO substrate (Nippon, 10 Ω/sq) was sequentially sonicated for 15 min in a detergent (2% diluted in DIW, Hellmanex III, Hellma GmbH), DIW, and ethanol. The cleaned FTO glass was exposed to UV/ozone treatment for 10 min. 0.1 M nickel nitrate hexahydrate (Sigma, 99.999%) in 2-methoxy ethanol (Roth, 99%) was deposited on the FTO glass using spin-coating at 4000 rpm for 20 s, which was followed by heating at 500 °C for 1 h with an increasing temperature rate of 16 °C/min. A closed box furnace without any gas flow was used for the annealing process. In the case of the cesium-mixed nickel precursor solution, cesium nitrate (Acros, 99.99%) was added to the nickel solution according to the required atomic ratio. The prepared perovskite solution was deposited on the NiO_x substrate using an antisolvent method.⁹ Briefly, 100 μL of chlorobenzene (Aldrich) was dropped on the substrate at the end of spinning (10 s before termination) of the perovskite precursor solution. The substrate coated with the perovskite precursor solution was heated at 100 °C for 50 min to be converted into the perovskite black phase. A PCBM (1-material) solution (20 mg/1 mL chlorobenzene) was deposited on the cooled down perovskite substrate by spin-coating at 5000 rpm for 30 s. Post-heat treatment for PCBM was carried out at 100 °C for 10 min. A bathocuproine (BCP, TCI, 98.0%) solution (0.5 mg/1 mL ethanol) was deposited for the hole blocking layer on the top of annealed PCBM using a spin-coater with 6000 rpm for 20 s. Gold was evaporated to make a ca. 75 nm-thick top electrode at 10^{−6} Torr. All the spin-coating procedures including perovskites, PCBM, and BCP were carried out in the glovebox filled with dry air.

Measurement. Current–voltage (I – V) curves and maximum power tracking were measured by a solar simulator (Oriel, OPS-A500) equipped with a 450 W xenon light source. A Schott K113 Tempax filter (PräzisionsGlas & Optik GmbH) was used to reduce the mismatch between the Xe lamp and a standard AM 1.5G light spectrum. A calibration for the light intensity was carried out prior to each measurement by the aid of a silicon reference cell equipped with an IR-cutoff filter (KG3, Schott). IS measurements were performed by a potentiostat (BioLogic, MPG 2) under a white LED light source. dc bias voltage was given from 0 to 0.8 V with a potential step of 100 mV. Sinusoidal ac voltage (20 mV)

ranging from 1 MHz to 1 Hz was put on the dc voltage. The measured data were fitted using ZView software with a simplified equivalent circuit composed of resistance (R) and three $R-C$ (resistance and capacitance in parallel) components in series. The recombination resistance was obtained from the last $R-C$ component corresponding to the low frequency. To avoid scattering effects of the glass substrate, an aperture with the black metal was attached to the device during all measurements ($I-V$, maximum power point tracking and IS) under illumination. The active area for the devices was 0.16 cm^2 . Absorption spectroscopy measurements were performed with a UV-vis-NIR spectrophotometer (Cary5, Varian). PL was measured by Fluorolog 322 (Horiba JobinYvon Ltd.). For the steady-state PL measurement, a wavelength of 450 nm was used for the excitation. For TR-PL, a single wavelength of 408 nm (N-405 L, Horiba) with 1 MHz was used for the excitation, and the resulting TR-PL was monitored at 750 nm. High-resolution scanning electron microscopy (HR-SEM) and EDXS were measured by ZEISS Merlin. XRD of the sample was measured using an Empyrean (PANalytical) instrument equipped with a ceramic tube (Cu anode, $\lambda = 1.54060\text{ \AA}$) and PIXel^{1D} (PANalytical). XRD data were analyzed using HighScore Plus software. HR-SEM images were obtained by ZEISS Merlin. XPS measurements were carried out using a PHI VersaProbe II scanning XPS microprobe (Physical Instruments AG, Germany). The samples for XRD and XPS measurements were prepared as powders by using the same precursor solutions for the NiO_x films. The precursor solution was coated on the large glass substrate and annealed in the same manner as for the NiO_x film. After the annealing process, the products were removed from the glass substrate and collected as powders. The conductivity study was made by a Precision LCR Meter (Agilent E4980A) at room temperature in ambient air.

■ ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsomega.7b01179.

Crystallographic parameters of NiO and $\text{Cs}_{0.1}\text{NiO}_2$, $\text{Ni } 2p_{3/2}$ XPS spectra of milled NiO_x surface SEM images, PL spectra, statistical photovoltaic parameters, $I-V$ hysteresis curve, and Nyquist plots (PDF)

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Notes

The authors declare no competing financial interest.

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